KAI-11002 Imager Board User's Manual

Description

The KAI-11002 Imager Evaluation Board, referred to in this document as the Imager Board, is designed to be used as part of a two-board set, in conjunction with a Timing Generator Board. ON Semiconductor offers an Imager Board / Timing Generator Board package that has been designed and configured to operate with the KAI-11002 Image Sensor.

The Timing Generator Board generates the timing signals necessary to operate the CCD, and provides the power required by the Imager Board. The timing signals, in LVDS format, and the power, are provided to the Imager Board via the interface connector (J1). In addition, the Timing Generator Board performs the processing and digitization of the analog video output of the Imager Board.

The KAI-11002 Imager Board has been designed to operate the KAI-11002 with the specified performance at



ON Semiconductor®

www.onsemi.com

EVAL BOARD USER'S MANUAL

30 MHz pixel clocking rate and nominal operating conditions. (See the KAI–11002 performance specifications for details).

For testing and characterization purposes, the KAI–11002 Imager Board provides the ability to adjust many of the CCD bias voltages and CCD clock level voltages by adjusting potentiometers on the board. The Imager Board provides the means to modify other device operating parameters (CCD reset clock pulse width, VSS bias voltage) by populating components differently on the board.

INPUT REQUIREMENTS

Power Supplies	Minimum	Typical	Maximum	Units
+5 V_MTR Supply	4.9	5.0	5.1	V
		1400		mA
-5 V_MTR Supply	-5.1	-5.0	-4.9	V
Γ		200		mA
VPLUS Supply	18	20	21	V
Γ		175		mA
VMINUS Supply	-21	-20	-18	V
		150		mA

Table 1. POWER REQUIREMENTS

Table 2. SIGNAL LEVEL REQUIREMENTS

Input Signals (LVDS)	V _{min}	V _{threshold}	V _{max}	Units	Comments
H1A (±)	0	±0.1	2.4	V	H1A clock
H1B (±)	0	±0.1	2.4	V	H1B clock
H2A (±)	0	±0.1	2.4	V	H2A clock
H2B (±)	0	±0.1	2.4	V	H2B clock
FDG	0	±0.1	2.4	V	Fast Dump clock
R (±)	0	±0.1	2.4	V	Reset clock
V1 (±)	0	±0.1	2.4	V	V1 clock
V2 (±)	0	±0.1	2.4	V	V2 clock
V2B (±)	0	±0.1	2.4	V	V2B clock
V3RD (±)	0	±0.1	2.4	V	V2 Clock 3 rd level
VES (±)	0	±0.1	2.4	V	Electronic Shutter
AMP_ENABLE (±)	0	±0.1	2.4	V	Output Amplifier Enable

ARCHITECTURE OVERVIEW

The following sections describe the functional blocks of the KAI–11002 Imager Board (Refer to Figure 1).

Power Filtering and Regulation

Power is supplied to the Imager Board via the J1 interface connector. The power supplies are de-coupled and filtered with ferrite beads and capacitors to suppress noise. Voltage regulators are used to create the +15 V and -15 V supplies from the VPLUS and VMINUS supplies.

LVDS Receivers / TTL Buffers

LVDS timing signals are input to the Imager Board via the J1 interface connector. These signals are shifted to TTL levels before being sent to the CCD clock drivers.

CCD Pixel-Rate Clock Drivers (H1, H2 & Reset Clocks)

The pixel rate CCD clock drivers utilize two fast switching transistors that are designed to translate TTL-level input clock signals to the voltage levels required by the CCD. The high and low voltage levels of the CCD clocks are set by potentiometers buffered by operational amplifiers configured as voltage followers.

For the H1A and H2A clock drivers, which require larger amounts of drive current due to the larger capacitive load presented by the CCD, the current source of the high and low voltage levels is a high current (up to 600 mA) transistor configured as an emitter follower. For better current drive capability, an extra pair of transistors may be populated in parallel. For the other clock drivers (H1L, RESET) that have much smaller loads, the drive current is supplied by the buffer op–amp itself.

Because the H1 and H2 clock rails are adjusted independently, the H1B and H2B clock driver voltage rails are selected by using four jumpers (E1–E4). In single output mode, the H1B and H2B rails are connected to the H1A and H2A rails, respectively. In dual output mode, the H1B and H2B rails should be connected to the H2A and H1A rails, respectively. See Table 5 for details.

H1L CCD Timing Adjustment Potentiometers

Minor timing adjustments can be made to the H1L CCD right and left clock positions using the delay adjust potentiometers R180 and R181. Each potentiometer, along with a capacitor, forms an RC network that acts to delay the position of the H1L clock with respect to the H1A clock.

Reset Clock One-Shot

The pulse width of the RESET_CCD clock is set by a programmable One–Shot. The One–Shot can be configured to provide a RESET_CCD clock signal with a pulse width from 5 ns to 15 ns.

CCD VCLK Drivers

The vertical clock (VCLK) drivers consist of MOSFET driver IC's. These drivers are designed to translate the

TTL-level clock signals to the voltage levels required by the CCD. The high, middle, and low voltage levels of the vertical clocks are set by potentiometers buffered by operational amplifiers configured as voltage followers. The current sources for these voltage levels are high current (up to 600 mA) transistors. The V2_CCD high level clock voltage is switched from V_MID to V_HIGH once per frame to transfer the charge from the photodiodes to the vertical CCDs. See Table 6 and Table 7 for vertical clocking voltage level options.

CCD FDG Voltages

The Fast Dump Gate (FDG) driver is a transistor that will switch the voltage on the FDG pin of the CCD from FDG_LOW to FDG_HIGH during Fast Dump Gate operation. When not in operation, or when the Fast Dump Gate feature is not being utilized, the FDG pin of the CCD is held at FDG_LOW. The FDG_HIGH and FDG_LOW voltage levels of the FDG driver are set by resistor divider circuits, and are buffered by operational amplifiers configured as voltage followers.

VES Circuit

The quiescent CCD substrate voltage (VSUB) is set by a potentiometer. For electronic shutter operation, the VES signal drives a transistor amplifier circuit which AC-couples the voltage difference between the VPLUS and VMINUS supplies onto the Substrate voltage. This creates the necessary potential to clear all charge from the photodiodes, thereby acting as an electronic shutter to control exposure.

CCD Bias Voltages

The CCD bias voltages are set by potentiometers, buffered by operational amplifiers configured as voltage followers. The bias voltages are de-coupled at the CCD pin.

Emitter-Follower

The VOUT_CCD signals are buffered using bipolar junction transistors in the emitter-follower configuration. These circuits also provide the necessary 5 mA current sink for the CCD output circuits.

CCD Image Sensor

This evaluation board supports the KAI-11002 Image Sensor.

Line Drivers

The buffered VOUT_CCD signals are AC-coupled and driven from the Imager Board by operational amplifiers in a non-inverting configuration. The operational amplifiers are configured to have a gain of 2, to correctly drive 75 Ω video coaxial cabling from the SMB connectors.

OPERATIONAL SETTINGS

The Imager board is configured to operate the KAI-11002 Image Sensors under the following operating conditions:

DC Bias Voltages

The following voltages are fixed, or adjusted with a potentiometer as noted. The nominal values listed in Table 3

Table 3. DC BIAS VOLTAGES

were correct at the time of this document's publication, but may be subject to change; refer to the KAI-11002 device specification.

Description	Symbol	Min	Nominal	Max	Units	Potentiometer	Notes
Left Output Amplifier Supply	VDDL		15.0		V		
Right Output Amplifier Supply	VDDR		15.0		V		1
Reset Drain	VRD	6.7	12.0	13.5	V	R15	3
ESD Protection	ESD		-9.0		V		
Substrate	VSUB	8.5	TBD	15.0	V	R18	3
Output Gate Left	VOGL	-7.5	-2.5	-0.4	V	R11	2, 3
Output Gate Right	VOGR	-7.5	-2.5	-0.4	V	R7	2, 3
Ground, P-well	GND		0.0		V		

1. If the CCD is to be operated in single output mode only (VOUT LEFT) the unused output amplifier supply can be tied to ground to conserve power by not populating R71, R72 and C76 and by replacing $\overline{C75}$ with a 0 Ω resistor. The Output Gate signals VOGL and VOGR may be controlled independently, or, by installing R28 and R33 and removing R29, may be set

2. to the same potential, controlled by R11.

3. The Min and Max voltages in the table indicate the imager board potentiometer adjustable voltage range. These values may exceed the specified CCD operating conditions. See the KAI-11002 device specification for details.

Clock Voltages

The following clock voltage levels are fixed, or adjusted with a potentiometer as noted. The nominal values listed in Table 4 were correct at the time of this document's publication, but may be subject to change; refer to the KAI-4011 / KAI-4021 /KAI-04022 device specification.

Description	Symbol	Level	Min	Nom	Max	Unit	Potentiometer	Notes
Horizontal CCD Clock - Phase 1A	H1A_CCD	Low	-7.5	-4	-0.8	V	R121	4
		High	0.4	2	7.5	V	R140	4
Horizontal CCD Clock - Phase 1B	H1B_CCD	Low	-7.5	-4	-0.8	V	R121	5, 10
		High	0.4	2	7.5	V	R140	5, 10
HCCD Last Gate Clock - Phase 1L	H1L_CCD	Low	-7.5	-4	-0.8	V	R95	6
		High	0.4	2	7.5	V	R80	6
Horizontal CCD Clock - Phase 2A	H2A_CCD	Low	-7.5	-4	-0.8	V	R121	7
		High	0.4	2	7.5	V	R140	7
Horizontal CCD Clock - Phase 2B	H2B_CCD	Low	-7.5	-4	-0.8	V	R121	8, 10
		High	0.4	2	7.5	V	R140	8, 10

Table 4. CLOCK VOLTAGES

4. Connected to CCD pins 8, 9, and 13 (H1SL, H1BL and H1SR)

5. Connected to CCD pin 12 (H1BR)

6. H1L Left connected to CCD pin 5 (H1BINL). H1L Right connected to CCD pin 16 (H1BINR)

7. Connected to CCD pins 7, 10, and 14 (H2SL, H2BL and H2SR)

8. Connected to CCD pin 11 (H2BR)

9. Four level vertical clocking mode only. See Table 6 and Table 7 Vertical Clocking Modes. Not applicable for all devices; see KAI-11002 device specifications.

10. H1B and H2B high and low clock voltages are connected either to H1A High and Low or H2A high and low depending on the output mode of operation. See Table 5.

Table 4. CLOCK VOLTAGES

Description	Symbol	Level	Min	Nom	Max	Unit	Potentiometer	Notes
Vertical CCD Clock - Phase 1	V1_CCD	–15 V		-15.0		V		9
		Low	-14	-9	-1	V	R40	
		Mid	-2.5	0	0	V	R66	
Vertical CCD Clock - Phase 2	V2_CCD	–15 V		-15.0				9
		Low	-14	-9	-1	V	R40	
		Mid	-2.5	0	0	V	R66	
		High	4	8	11	V	R48	
Reset Clock	RESET_CCD	Low	-7	-3.5	-1	V	R166	
		High	1	1.5	7	V	R154	
Fast Dump Clock	FDG_CCD	Low		-9		V		
		High		5		V		

4. Connected to CCD pins 8, 9, and 13 (H1SL, H1BL and H1SR)

5. Connected to CCD pin 12 (H1BR)
6. H1L Left connected to CCD pin 5 (H1BINL). H1L Right connected to CCD pin 16 (H1BINR)

Connected to CCD pins 7, 10, and 14 (H2SL, H2BL and H2SR)
Connected to CCD pin 11 (H2BR)

9. Four level vertical clocking mode only. See Table 6 and Table 7 Vertical Clocking Modes. Not applicable for all devices; see KAI-11002 device specifications.

10. H1B and H2B high and low clock voltages are connected either to H1A High and Low or H2A high and low depending on the output mode of operation. See Table 5.

Table 5. HCLK JUMPER SETTINGS

Jumper	Setting	Clock Level	Voltage Set To	Notes
E1	10UT	H2B_LOW	H1A LOW	Default
E1	20UT	H2B_LOW	H2A LOW	
E2	10UT	H1B_HIGH	H2A HIGH	Default
E2	20UT	H1B_HIGH	H1A HIGH	
E3	10UT	H2B_HIGH	H1A HIGH	Default
E3	20UT	H2B_HIGH	H2A HIGH	
E4	10UT	H1B_LOW H2A LOW		Default
E4	20UT	H1B_LOW H1A LOW		

Table 6. V1 VERTICAL CLOCKING MODES

V1_CCD Voltage	V1_TTL	V2B_TTL	Notes
V_MID	0	0	
V_MID	0	1	
V_LOW	1	0	
–15 V	1	1	Four level vertical clocking mode only. Not applicable for all devices, see device specifications.

Table 7. V2 VERTICAL CLOCKING MODES

V2_CCD Voltage	V3RD_TTL	V2_TTL	V2B_TTL	Notes
V_MID	0	0	0	
V_HIGH	1	0	0	
V_LOW	0	1	0	
V_LOW	1	1	0	
V_MID	0	0	1	
V_HIGH	1	0	1	
–15 V	0	1	1	Four level vertical clocking mode only. Not applicable for all devices, see device specifications.
–15 V	1	1	1	Four level vertical clocking mode only. Not applicable for all devices, see device specifications.

Reset Clock Pulse Width

The pulse width of RESET_CCD is set by configuring P[2..0], the inputs to the programmable one-shot. P[2..0]

can be tied high or low to achieve the desired pulse width by populating the resistors R161–164 accordingly.

Table 8. RESET CLOCK PULSE WIDTH

Pulse Width	P0	P1	P2	R161	R162	R163	R164	Notes
15 ns	0	0	0	IN	IN	OUT	OUT	
5 ns	1	0	0	IN	OUT	IN	OUT	Default Setting
7.5 ns	0	1	0	OUT	IN	OUT	IN	
10 ns	1	1	0	OUT	OUT	IN	IN	

BLOCK DIAGRAM AND PERFORMANCE DATA

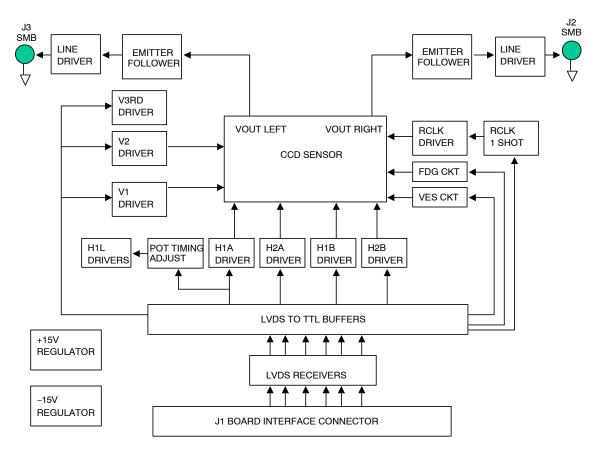
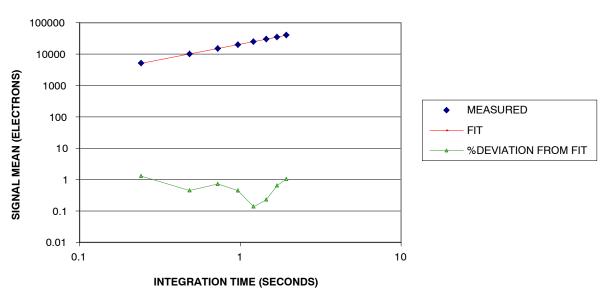


Figure 1. KAI–11002 Imager Board Block Diagram



LINEARITY



Photon Transfer

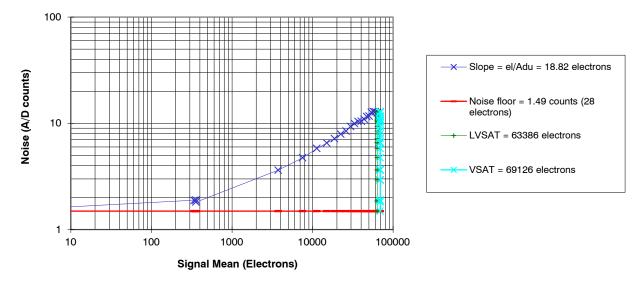


Figure 3. Measured Performance – Dynamic Range and Noise Floor

CONNECTOR ASSIGNMENTS AND PINOUTS

SMB Connectors J2 and J3

The emitter-follower buffered CCD_VOUT signals are driven from the Imager Board via the SMB connectors J2 and J3. Coaxial cable with a characteristic impedance of

75 Ω should be used to connect the imager board to the Timing Generator Board to match the series and terminating resistors used on these boards.

Table 9. J1 INTERFACE CONNECTOR PIN ASSIGNMENTS

Pin	Signal	Pin	Signal
1	N.C.	2	N.C.
3	AGND	4	AGND
5	VES+	6	VES-
7	AGND	8	AGND
9	FDG+	10	FDG-
11	AGND	12	AGND
13	V3RD+	14	V3RD-
15	AGND	16	AGND
17	V2B+	18	V2B-
19	AGND	20	AGND
21	V2+	22	V2-
23	AGND	24	AGND
25	V1+	26	V1-
27	AGND	28	AGND
29	R+	30	R-
31	AGND	32	AGND
33	H2B+	34	H2B-
35	AGND	36	AGND
37	H2A+	38	H2A-
39	AGND	40	AGND
41	H1B+	42	H1B-
43	AGND	44	AGND
45	H1A+	46	H1A–
47	N.C.	48	N.C.
49	AGND	50	AGND
51	N.C.	52	N.C.
53	VMINUS_MTR	54	VMINUS_MTR
55	N.C.	56	N.C.
57	AGND	58	AGND
59	AMP_ENABLE+	60	AMP_ENABLE-
61	–5 V_MTR	62	–5 V_MTR
63	N.C.	64	N.C.
65	AGND	66	AGND
67	N.C.	68	N.C.
69	+5 V_MTR	70	+5 V_MTR
71	N.C.	72	N.C.
73	AGND	74	AGND
75	N.C.	76	N.C.
77	VPLUS_MTR	78	VPLUS_MTR
79	N.C.	80	N.C.

Warnings and Advisories

ON Semiconductor is not responsible for customer damage to the Imager Board or Imager Board electronics. The customer assumes responsibility and care must be taken when probing, modifying, or integrating the ON Semiconductor Evaluation Board Kits.

When programming the Timing Board, the Imager Board must be disconnected from the Timing Board before power is applied. If the Imager Board is connected to the Timing Board during the reprogramming of the Altera PLD, damage to the Imager Board will occur.

Purchasers of an Evaluation Board Kit may, at their discretion, make changes to the Timing Generator Board firmware. ON Semiconductor can only support firmware developed by, and supplied by, ON Semiconductor. Changes to the firmware are at the risk of the customer.

Ordering Information

Please address all inquiries and purchase orders to:

Truesense Imaging, Inc. 1964 Lake Avenue Rochester, New York 14615 Phone: (585) 784–5500 E-mail: info@truesenseimaging.com

ON Semiconductor reserves the right to change any information contained herein without notice. All information furnished by ON Semiconductor is believed to be accurate. onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf, onsemi is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

The evaluation board/kit (research and development board/kit) (hereinafter the "board") is not a finished product and is not available for sale to consumers. The board is only intended for research, development, demonstration and evaluation purposes and will only be used in laboratory/development areas by persons with an engineering/technical training and familiar with the risks associated with handling electrical/mechanical components, systems and subsystems. This person assumes full responsibility/liability for proper and safe handling. Any other purpose is strictly prohibited.

THE BOARD IS PROVIDED BY ONSEMI TO YOU "AS IS" AND WITHOUT ANY REPRESENTATIONS OR WARRANTIES WHATSOEVER. WITHOUT LIMITING THE FOREGOING, ONSEMI (AND ITS LICENSORS/SUPPLIERS) HEREBY DISCLAIMS ANY AND ALL REPRESENTATIONS AND WARRANTIES IN RELATION TO THE BOARD, ANY MODIFICATIONS, OR THIS AGREEMENT, WHETHER EXPRESS, IMPLIED, STATUTORY OR OTHERWISE, INCLUDING WITHOUT LIMITATION ANY AND ALL REPRESENTATIONS AND WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, TITLE, NON-INFRINGEMENT, AND THOSE ARISING FROM A COURSE OF DEALING, TRADE USAGE, TRADE CUSTOM OR TRADE PRACTICE.

onsemi reserves the right to make changes without further notice to any board.

You are responsible for determining whether the board will be suitable for your intended use or application or will achieve your intended results. Prior to using or distributing any systems that have been evaluated, designed or tested using the board, you agree to test and validate your design to confirm the functionality for your application. Any technical, applications or design information or advice, quality characterization, reliability data or other services provided by **onsemi** shall not constitute any representation or warranty by **onsemi**, and no additional obligations or liabilities shall arise from **onsemi** having provided such information or services.

onsemi products including the boards are not designed, intended, or authorized for use in life support systems, or any FDA Class 3 medical devices or medical devices with a similar or equivalent classification in a foreign jurisdiction, or any devices intended for implantation in the human body. You agree to indemnify, defend and hold harmless onsemi, its directors, officers, employees, representatives, agents, subsidiaries, affiliates, distributors, and assigns, against any and all liabilities, losses, costs, damages, judgments, and expenses, arising out of any claim, demand, investigation, lawsuit, regulatory action or cause of action arising out of or associated with any unauthorized use, even if such claim alleges that onsemi was negligent regarding the design or manufacture of any products and/or the board.

This evaluation board/kit does not fall within the scope of the European Union directives regarding electromagnetic compatibility, restricted substances (RoHS), recycling (WEEE), FCC, CE or UL, and may not meet the technical requirements of these or other related directives.

FCC WARNING – This evaluation board/kit is intended for use for engineering development, demonstration, or evaluation purposes only and is not considered by **onsemi** to be a finished end product fit for general consumer use. It may generate, use, or radiate radio frequency energy and has not been tested for compliance with the limits of computing devices pursuant to part 15 of FCC rules, which are designed to provide reasonable protection against radio frequency interference. Operation of this equipment may cause interference with radio communications, in which case the user shall be responsible, at its expense, to take whatever measures may be required to correct this interference.

onsemi does not convey any license under its patent rights nor the rights of others.

LIMITATIONS OF LIABILITY: **onsemi** shall not be liable for any special, consequential, incidental, indirect or punitive damages, including, but not limited to the costs of requalification, delay, loss of profits or goodwill, arising out of or in connection with the board, even if **onsemi** is advised of the possibility of such damages. In no event shall **onsemi**'s aggregate liability from any obligation arising out of or in connection with the board, under any theory of liability, exceed the purchase price paid for the board, if any.

The board is provided to you subject to the license and other terms per **onsemi**'s standard terms and conditions of sale. For more information and documentation, please visit www.onsemi.com.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support: Phone: 00421 33 790 2910 For additional information, please contact your local Sales Representative